

### **Electrostatic Discharged Protection Devices (ESD) Data Sheet**

#### **Description**

Brightking's SDT26AXXL05 series are designed to protect sensitive electronics from damage or latch-up due to ESD and other voltage induced transient events. Each device will protect up to five lines. They are unidirectional devices and may be used on lines where the signal polarities are above ground.

They feature large cross sectional area junctions for conducting high transient currents. They offer desirable characteristics for board level protection including fast response time, low operating and clamping voltage and no device degradation. The series may be used to meet the immunity requirements of IEC61000-4-2, level 4.

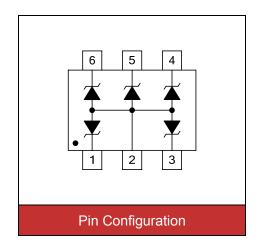


Contact: ±8kV Air: ±15kV



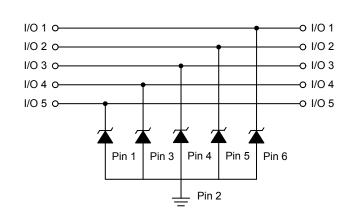
#### **Features**

- IEC61000-4-2 ESD 15KV Air, 8KV contact compliance
- SOT23-6L surface mount package
- Protects five data lines
- Peak power dissipation of 350W under 8/20µs waveform
- Working voltage: 5V, 15V and 24V
- Low leakage current
- Low clamping voltage
- Solid-state silicon avalanche technology
- Lead Free/RoHS compliant
- Solder reflow temperature: Pure Tin-Sn, 260~270°C
- Flammability rating UL 94V-0
- Meets MSL level 1, per J-STD-020



### **Applications**

- Cell phone handsets and accessories
- Microprocessor based equipment
- Personal digital assistants (PDA's)
- Notebooks, Desktops and Servers
- Portable instrumentation
- Set Top Box
- Peripherals
- Cordless phones





# Maximum Ratings

Rating	Symbol	Value	Unit
Peak pulse power (tp=8/20µs waveform)	P <sub>PP</sub>	350	W
ESD voltage (Contact discharge)	V	±8	12/
ESD voltage (Air discharge)	$V_{ESD}$	±15	kV
Lead soldering temperature	TL	260	${\mathbb C}$
Storage & operating temperature range	T <sub>STG</sub> ,T <sub>J</sub>	-55~+150	${\mathbb C}$

# Electrical Characteristics (T<sub>J</sub>=25℃)

SDT26A05L05 (Marking: TC5)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Reverse stand-off voltage	$V_{RWM}$				5	V
Reverse breakdown voltage	$V_{BR}$	I <sub>BR</sub> =1mA	6			V
Reverse leakage current	I <sub>R</sub>	V <sub>R</sub> =5V Each I/O pin			5	μΑ
Clamping voltage (tp=8/20µs)	V <sub>C</sub>	I <sub>PP</sub> =5A			9.5	V
Clamping voltage (tp=8/20µs)	V <sub>C</sub>	I <sub>PP</sub> =20A			18	V
Off state junction capacitance	Сл	0Vdc,f=1MHz Between I/O pins			200	pF

SDT26A15L05 (Marking: TCJ)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Reverse stand-off voltage	$V_{RWM}$				15	V
Reverse breakdown voltage	$V_{BR}$	I <sub>BR</sub> =1mA	16.7			V
Reverse leakage current	I <sub>R</sub>	V <sub>R</sub> =15V Each I/O pin			5	μA
Clamping voltage (tp=8/20µs)	V <sub>C</sub>	I <sub>PP</sub> =5A			24	V
Clamping voltage (tp=8/20µs)	V <sub>C</sub>	I <sub>PP</sub> =10A			35	V
Off state junction capacitance	CJ	0Vdc,f=1MHz Between I/O pins			70	pF

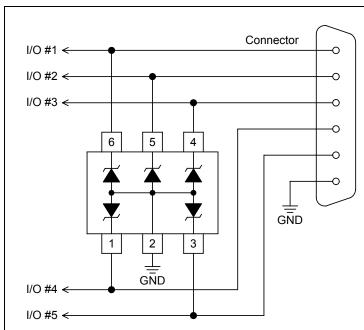


#### **Electrical Characteristics (T<sub>J</sub>=25** °C)

SDT26A24L05 (Marking: TCK)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
Reverse stand-off voltage	$V_{RWM}$				24	V
Reverse breakdown voltage	$V_{BR}$	I <sub>BR</sub> =1mA	26.7			V
Reverse leakage current	I <sub>R</sub>	V <sub>R</sub> =24V Each I/O pin			1	μA
Clamping voltage (tp=8/20µs)	V <sub>C</sub>	I <sub>PP</sub> =5A			40	V
Clamping voltage (tp=8/20µs)	V <sub>C</sub>	I <sub>PP</sub> =7A			50	V
Off state junction capacitance	CJ	0Vdc,f=1MHz Between I/O pins			50	pF

#### **Applications Information**



Unidirectional protection of five I/O lines is achieved by connecting pins 1, 3, 4, 5 and 6 to the data lines. Pin 2 is connected to ground. The ground connection should be made directly to the ground plane for best results.

The path length is kept as short as possible to reduce the effects of parasitic inductance in the board traces.

Figure 1. Keep short path length

Good circuit board layout is critical for the suppression of ESD induced transients.

The following guidelines are recommended:

- Place the SDT26AXXL05 near the input terminals or connectors to restrict transient coupling
- Minimize the path length between the SDT26AXXL05 and the protected line
- Minimize all conductive loops including power and ground loops.
- The ESD transient return path to ground should be kept as short as possible.
- Never run critical signals near board edges.
- Use ground planes whenever possible.



### **Typical Characteristics Curves**

Figure 1. Power Derating Curve

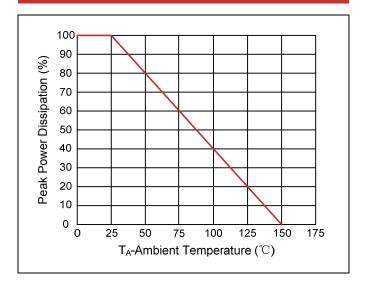


Figure 2. Pulse Waveforms

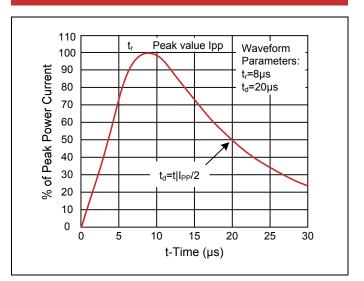


Figure 3. Non-Repetitive Peak Pulse vs. Pulse Time

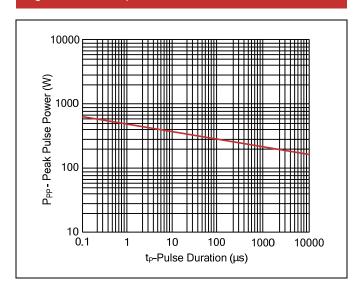
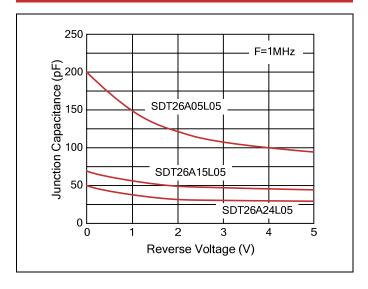
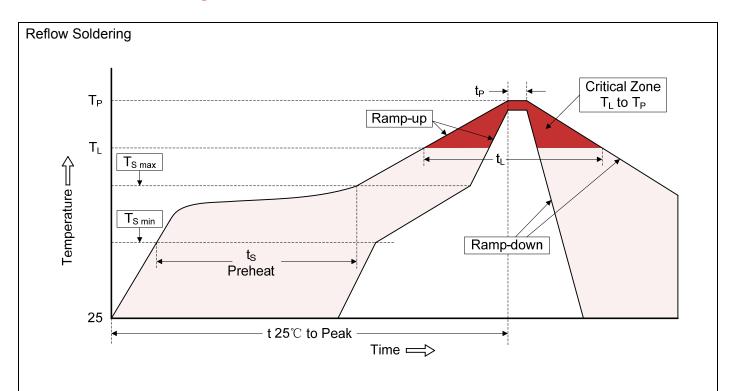


Figure 4. Capacitance vs. Reverse Voltage





## **Recommended Soldering Conditions**

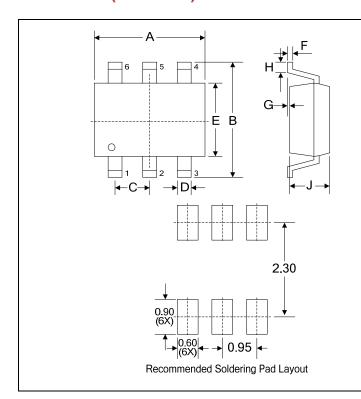


#### **Recommended Conditions**

Profile Feature	Pb-Free Assembly
Average ramp-up rate (T <sub>L</sub> to T <sub>P</sub> )	3℃/second max.
Preheat	
-Temperature Min (T <sub>S min</sub> )	150℃
-Temperature Max (T <sub>S max</sub> )	200℃
-Time (min to max) (ts)	60-180 seconds
T <sub>S max</sub> to T <sub>L</sub>	
-Ramp-up Rate	3℃/second max.
Time maintained above:	
-Temperature (T <sub>L</sub> )	217℃
-Time (t <sub>L</sub> )	60-150 seconds
Peak Temperature (T <sub>P</sub> )	260℃
Time within 5°C of actual Peak Temperature (t <sub>P</sub> )	20-40 seconds
Ramp-down Rate	6℃/second max.
Time 25℃ to Peak Temperature	8 minutes max.



# **Dimensions (SOT23-6L)**



	Dimension				
Symbol	Millim	neters	Inches		
Min.		Max.	Min.	Max.	
Α	2.80	3.00	0.110	0.118	
В	2.60	3.00	0.102	0.118	
С	0.93	0.97	0.037	0.038	
D	0.4	41	0.0	)16	
Е	1.50	1.70	0.059	0.067	
F	0.11	0.19	0.004	0.007	
G	-	0.10	-	0.004	
Н	0.40	-	0.016	-	
J	1.00	1.20	0.393	0.047	

### **Packaging**

